Window and Dome Technologies and Materials X

Randal W. Tustison
Editor

11–12 April 2007
Orlando, Florida, USA

Sponsored and Published by
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Please use the following format to cite material from this book:


ISSN 0277-786X
ISBN 97808194666679

Published by
SPIE—The International Society for Optical Engineering
P.O. Box 10, Bellingham, Washington 98227-0010 USA
Telephone 1 360/676-3290 (Pacific Time)· Fax 1 360/647-1445
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Printed in the United States of America.
Contents

vii Conference Committee

SESSION 1 LONG-WAVELENGTH INFRARED TRANSPARENT MATERIALS

654502 Development of hot-pressed and chemical-vapor-deposited zinc sulfide and zinc selenide in the United States for optical windows (Invited Paper) [6545-01]
D. C. Harris, Naval Air Systems Command (USA)

654503 International development of chemical vapor deposited zinc sulfide [6545-02]
J. McCloy, Raytheon Missile Systems (USA)

654504 Optical properties of epitaxial single-crystal chemical-vapor-deposited diamond [6545-03]
G. Turri, Y. Chen, M. Bass, CREOL/College of Optics and Photonics/Univ. of Central Florida (USA); D. Orchard, QinetiQ Ltd. (United Kingdom); J. E. Butler, S. Magana, T. Feygelson, D. Thiel, K. Fourspring, Naval Research Lab. (USA); J. Pentony, S. Hawkins, M. Baronowski, R. V. Dewees, M. D. Seltzer, A. Guenthner, D. C. Harris, Naval Air Systems Command (USA); C. M. Stickley, DARPA (USA)

654505 Spectral characterization of diffractively structured GaAs using the ARISTMS [6545-04]
P. Coulter, M. Wilson, MilSys Technologies, LLC (USA)

SESSION 2 GLASSES

654507 Fluorinated silicate glass for conventional and holographic optical elements [6545-06]
L. Glebov, CREOL/College of Optics and Photonics/Univ. of Central Florida (USA)

654508 Development of a laser glass for the National Ignition Facility [6545-07]
J. S. Hayden, SCHOTT North America, Inc. (USA); J. H. Campbell, S. A. Payne, Lawrence Livermore National Lab. (USA)

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The CID number appears on each page of the manuscript. The complete citation is used on the first page, and an abbreviated version on subsequent pages.
### SESSION 3 MICRO- AND NANO-CRYSTALLINE OPTICAL MATERIALS AND STRUCTURES

<table>
<thead>
<tr>
<th>Session 3</th>
<th>Title</th>
<th>Authors/Institutions</th>
</tr>
</thead>
<tbody>
<tr>
<td>654509</td>
<td>Spark plasma sintering and forming of transparent polycrystalline Al_2O_3 windows and domes [6545-49]</td>
<td>D. Jiang, D. M. Hulbert, U. Anselmi-Tamburini, T. Ng, D. Land, A. K. Muhkerjee, Univ. of California, Davis (USA)</td>
</tr>
</tbody>
</table>

### SESSION 4 MODELING, CHARACTERIZATION, AND FABRICATION I

<table>
<thead>
<tr>
<th>Session 4</th>
<th>Title</th>
<th>Authors/Institutions</th>
</tr>
</thead>
<tbody>
<tr>
<td>65450G</td>
<td>Erosion studies of infrared dome materials [6545-16]</td>
<td>R. M. Sullivan, Naval Air Warfare Ctr. {USA}; A. Phelps, Univ. of Dayton Research Institute (USA); J. C. Kirsch, U.S. Army Aviation and Missile RDEC (USA); E. A. Welsh, Lockheed Martin Missiles and Fire Control (USA); D. C. Harris, Naval Air Systems Command (USA)</td>
</tr>
<tr>
<td>65450I</td>
<td>BRDF and BSDF models for diffuse surface and bulk scatter from transparent windows [6545-18]</td>
<td>M. E. Thomas, Johns Hopkins Univ. Applied Physics Lab. (USA); D. D. Duncan, Oregon Health and Science Univ. (USA)</td>
</tr>
<tr>
<td>65450K</td>
<td>Characterization of AFB sapphire single crystal composites for infrared window application [6545-20]</td>
<td>H.-C. Lee, H. E. Meissner, Onyx Optics, Inc. (USA)</td>
</tr>
<tr>
<td>65450L</td>
<td>Simulation and experimental results of sub-aperture transmitted wavefront measurements of a window using a time-delayed source [6545-21]</td>
<td>M. B. Dubin, Breault Research Organization (USA); W. P. Kuhn, Opt-E (USA)</td>
</tr>
</tbody>
</table>

### SESSION 5 MODELING, CHARACTERIZATION, AND FABRICATION II

<table>
<thead>
<tr>
<th>Session 5</th>
<th>Title</th>
<th>Authors/Institutions</th>
</tr>
</thead>
<tbody>
<tr>
<td>65450O</td>
<td>Time-delayed source and interferometric measurement of domes and windows [6545-24]</td>
<td>W. P. Kuhn, Opt-E (USA); M. Dubin, Breault Research Organization (USA)</td>
</tr>
<tr>
<td>Session 6</td>
<td>Optical Coatings and Surface Structures</td>
<td></td>
</tr>
<tr>
<td>-----------</td>
<td>-----------------------------------------</td>
<td></td>
</tr>
<tr>
<td>65450P</td>
<td>Laser-assisted pre-finishing of optical ceramic materials [6545-25]</td>
<td></td>
</tr>
<tr>
<td></td>
<td>J. C. Rozzi, O. H. Clavier, M. D. Barton, Creare Inc. (USA)</td>
<td></td>
</tr>
<tr>
<td>65450Q</td>
<td>Developments in the finishing of domes and conformal optics [6545-26]</td>
<td></td>
</tr>
<tr>
<td></td>
<td>A. B. Shorey, W. Kordonski, J. Tracy, M. Tricard, QED Technologies (USA)</td>
<td></td>
</tr>
<tr>
<td>65450R</td>
<td>Contact mechanics models and algorithms for dome polishing with UltraForm Finishing (UFF) [6545-27]</td>
<td></td>
</tr>
<tr>
<td></td>
<td>C. Bouvier, S. M. Gracewski, S. J. Burns, Univ. of Rochester (USA)</td>
<td></td>
</tr>
<tr>
<td>65450S</td>
<td>Improving surface figure and microroughness of IR materials and diamond turned surfaces with magnetorheological finishing (MRF) [6545-28]</td>
<td></td>
</tr>
<tr>
<td></td>
<td>C. Supranowitz, C. Hall, P. Dumas, B. Hallock, QED Technologies (USA)</td>
<td></td>
</tr>
</tbody>
</table>

<table>
<thead>
<tr>
<th>Session 7</th>
<th>Visible to Mid-Wavelength Infrared Transparent Materials and Applications</th>
</tr>
</thead>
<tbody>
<tr>
<td>654512</td>
<td>An improved soft-chemistry approach to the preparation of spinel powders [6545-38]</td>
</tr>
<tr>
<td></td>
<td>R. Cook, TDA Research, Inc. (USA)</td>
</tr>
<tr>
<td>654514</td>
<td>Polycrystalline transparent spinel domes for multimode seeker applications [6545-40]</td>
</tr>
<tr>
<td></td>
<td>A. A. DiGiovanni, A. LaRoche, L. Schubel, L. Fehrenbacher, Technology Assessment and Transfer (USA); D. W. Roy, Consultant (USA)</td>
</tr>
<tr>
<td>654517</td>
<td>Critical parameters for grinding large sapphire window panels [6545-43]</td>
</tr>
<tr>
<td>654519</td>
<td>Improvements in large window and optics production [6545-45]</td>
</tr>
<tr>
<td></td>
<td>B. Hallock, B. Messner, C. Hall, C. Supranowitz, QED Technologies (USA)</td>
</tr>
</tbody>
</table>
Reduced angle-shift infrared bandpass filter coatings [6545-48]
B. M. Lairson, J. Mosier, K. Gibbons, J. H. Sternbergh, M. A. George, Deposition Sciences, Inc. (USA)
Conference Committee

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John McCloy, Raytheon Missile Systems (USA)
Robert J. Ondercin, Air Force Research Laboratory (USA)
Roger M. Sullivan, Naval Air Warfare Center (USA)
Michael E. Thomas, Johns Hopkins University Applied Physics Laboratory (USA)

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1 Long-wavelength Infrared Transparent Materials
   Michael E. Thomas, Johns Hopkins University Applied Physics Laboratory (USA)

2 Glasses
   Richard L. Gentilman, Raytheon Integrated Defense Systems (USA)

3 Micro- and Nano-crystalline Optical Materials and Structures
   Daniel C. Harris, Naval Air Systems Command (USA)

4 Modeling, Characterization, and Fabrication I
   John McCloy, Raytheon Missile Systems (USA)
5 Modeling, Characterization, and Fabrication II  
James C. Kirsch, U.S. Army Research, Development and Engineering Command (USA) and U.S. Army Aviation and Missile Command (USA)

6 Optical Coatings and Surface Structures  
Robert J. Ondercin, Air Force Research Laboratory (USA)

7 Visible to Mid-wavelength Infrared Transparent Materials and Applications  
Joel Askinazi, Goodrich Corporation (USA)